

Form PTO 1449
(Modified)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY DOCKET NO.
210314US2SERIAL NO.
09/895,319

LIST OF REFERENCES CITED BY APPLICANT

APPLICANT
Toshiaki SHINOHARAFILING DATE
July 2, 2001GROUP
2814

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
<i>DLR</i>	AA 5,598,034	01/28/1997	G. F. WAKEFIELD, et al.			
<i>DLR</i>	AB 5,317,194	05/31/1994	S. SAKO			
<i>DLR</i>	AC 5,440,169	08/08/1995	Y. TOMITA, et al.			
<i>DLR</i>	AD 5,986,336	11/16/1999	Y. TOMITA			
<i>DLR</i>	AE 5,767,573	06/16/1998	S. NODA, et al.			
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FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
				YES	NO
<i>DLR</i>	AO 44 00 341	07/14/1994	GERMANY (with corr. US 5,440,169)		X
<i>DLR</i>	AP 197 00 056	09/25/1997	GERMANY (with corr. US 5,986,336)		X
<i>DLR</i>	AQ 196 25 240	04/30/1997	GERMANY (with corr. US 5,767,573)		X
<i>DLR</i>	AR 11-243186	07/09/1999	JAPAN (with English Extract)		X
<i>DLR</i>	AS 0 777 272	06/04/1997	EUROPE		
	AT				
	AU				
	AV				

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
	AZ	

☐ Additional References sheet(s) attached

Examiner

Date Considered

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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AP	197 00 056	09/25/1997	GERMANY (with corr. US 5,986,336)		X
AQ	196 25 240	04/30/1997	GERMANY (with corr. US 5,767,573)		X
AR	11-243166	07/09/1999	JAPAN (with English Extract)		X
AS	0 777 272	06/04/1997	EUROPE		
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Examiner

Date Considered 2/17/05

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10/19/09



SHEET 1 OF 1

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U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
<i>DLR</i>	AA 5,057,906	10/15/1991	Toshio ISHIGAMI (corresponding to Korean Patent No. 0065249)			
	AB					
	AC					
	AD					
	AE					
	AF					
	AG					
	AH					
	AI					
	AJ					
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	AL					
	AM					
	AN					

FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
				YES	NO
<i>DLR</i>	AO 11-17071	01/22/1999	Japan (with partial English translation)		X
<i>DLR</i>	AP 0065249	04/10/1993	Korea (with corresponding US Patent No. 5,057,906)		X
	AQ				
	AR				
	AS				
	AT				
	AU				
	AV				

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

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Examiner

Adrian Shuyun

Date Considered

2/17/05

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